

January 2012

FDMS7650

N-Channel PowerTrench® MOSFET 30 V, 100 A, 0.99 m Ω

Features

- Max $r_{DS(on)} = 0.99 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 36 \text{ A}$
- Max $r_{DS(on)}$ = 1.55 m Ω at V_{GS} = 4.5 V, I_D = 32 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

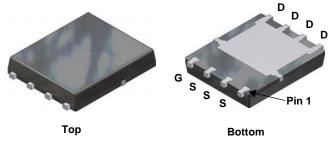


General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge and extremely low $r_{DS(on)}$.

Applications

- OringFET
- Synchronous rectifier



Power 56

D 5 4 G D 6 3 S D 7 2 S D 8 1 S

MOSFET Maximum Ratings T_C = 25 ℃ unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 ℃		100	
I _D	-Continuous (Silicon limited) $T_C = 25 ^{\circ}\text{C}$			232	^
	-Continuous	T _A = 25 ℃	(Note 1a)	36	Α
	-Pulsed			200	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	544	mJ
D	Power Dissipation	T _C = 25 ℃		104	W
P_D	Power Dissipation	T _A = 25 ℃	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	C

Thermal Characteristics

$R_{ heta JC}$	Thermal Resistance, Junction to Case	1.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7650	FDMS7650	Power 56	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		15		mV/℃
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	1.9	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25 °C		-6		mV/℃
		V _{GS} = 10 V, I _D = 36 A		0.8	0.99	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 32 \text{ A}$		1.1	1.55	mΩ
		$V_{GS} = 10 \text{ V}, I_D = 36 \text{ A}, T_J = 125 ^{\circ}\text{C}$		1.1	1.7	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 36 A		267		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 45 V V 0 V	11250	14965	pF
C _{oss}	Output Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	3050	4055	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	240	360	pF
R_g	Gate Resistance		1.4	3	Ω

Switching Characteristics

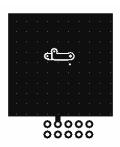
t _{d(on)}	Turn-On Delay Time		28	45	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 36 A,	24	38	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	83	133	ns
t _f	Fall Time		21	34	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	149	209	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$	63	88	nC
Q _{gs}	Gate to Source Charge	I _D = 36 A	34		nC
Q_{gd}	Gate to Drain "Miller" Charge		13		nC

Drain-Source Diode Characteristics

V _{SD} Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.1 A$ (Note 2)	0.7	1.2	V	
V _{SD}	SD Source to Drain blode Forward voltage	$V_{GS} = 0 \text{ V}, I_S = 36 \text{ A}$ (Note 2)	0.8	1.3	V
t _{rr}	Reverse Recovery Time	I _F = 36 A, di/dt = 100 A/μs	69	97	ns
Q _{rr}	Reverse Recovery Charge	1F = 36 A, α/αι = 100 A/μs	56	90	nC

Notes

^{1.} R_{eJA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{eJC} is guaranteed by design while R_{eCA} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 ms, Duty cycle < 2.0%.
- 3. Starting T_J = 25 °C, L = 1 mH, I $_{\mbox{AS}}$ = 33 A, $V_{\mbox{DD}}$ = 27 V, $V_{\mbox{GS}}$ = 10 V.
- $4. \ As \ an \ N-ch \ device, the \ negative \ Vgs \ rating \ is \ for \ low \ duty \ cycle \ pulse \ ocurrence \ only. \ No \ continuous \ rating \ is \ implied.$

Typical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

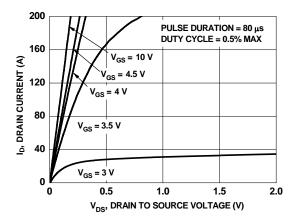


Figure 1. On Region Characteristics

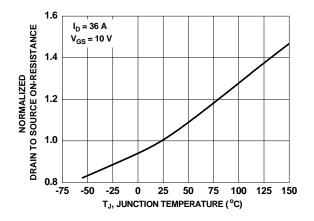


Figure 3. Normalized On Resistance vs Junction Temperature

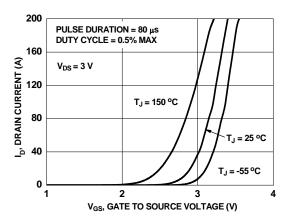


Figure 5. Transfer Characteristics

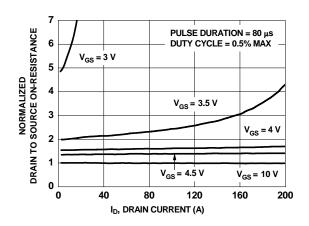


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

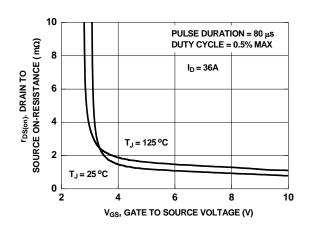


Figure 4. On-Resistance vs Gate to Source Voltage

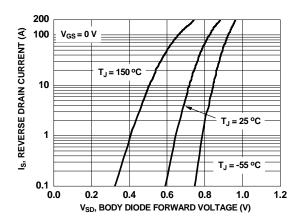


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25 \text{ } \text{C}$ unless otherwise noted

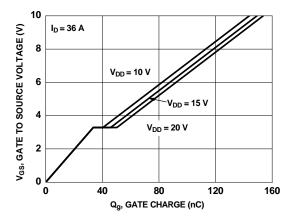


Figure 7. Gate Charge Characteristics

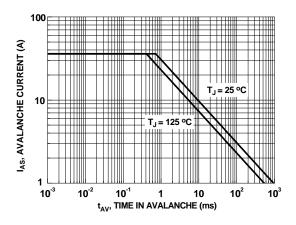


Figure 9. Unclamped Inductive Switching Capability

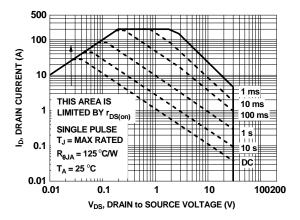


Figure 11. Forward Bias Safe Operating Area

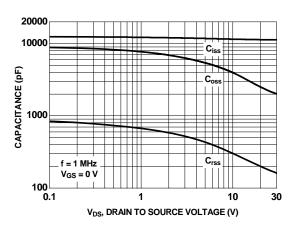


Figure 8. Capacitance vs Drain to Source Voltage

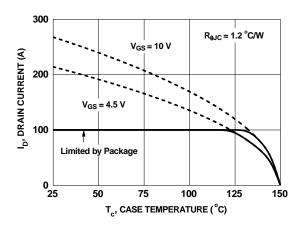


Figure 10. Maximum Continuous Drain Current vs Case Temperature

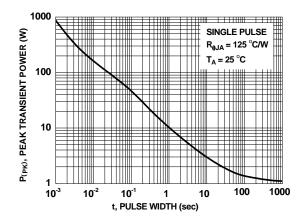


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25 \ {\rm C}$ unless otherwise noted

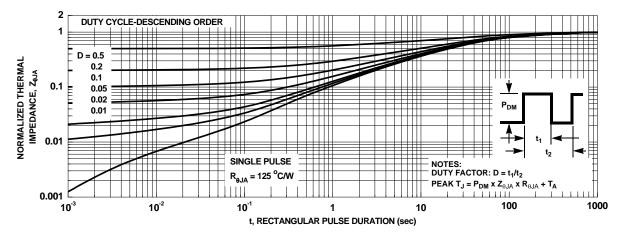
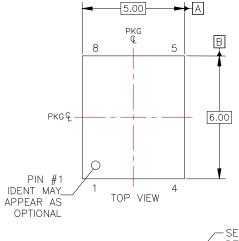
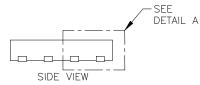
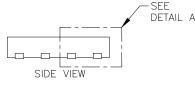


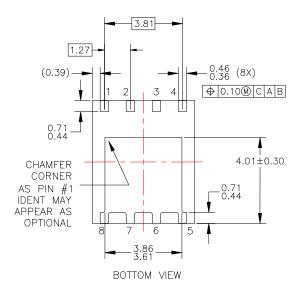
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

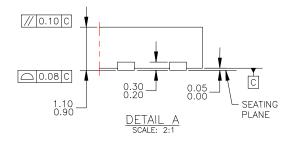
Dimensional Outline and Pad Layout

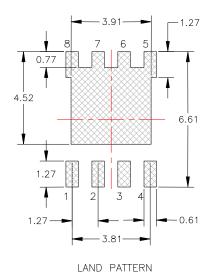




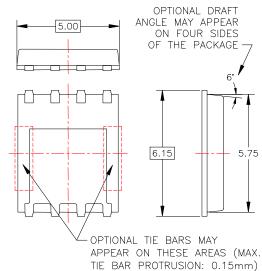








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